

N-Channel Enhancement Mode Field Effect Transistor

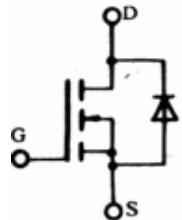
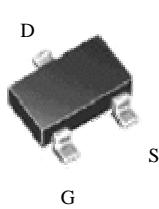
FEATURES

- Super high dense cell design for low R_{DSON}
- Rugged and reliable
- Simple drive requirement
- SOT-23 package

PRODUCT SUMMARY		
V _{DSS}	I _D	R _{DSON} (mΩ) Typ
20V	3.6A	65@ V _{GS} =4.5V
		90@ V _{GS} =2.5V



NOTE: The Si2302 is available in a lead-free package



ABSOLUTE MAXIMUM RATINGS (T_A=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	20	V
Gate-Source Voltage	V _{GS}	±8	V
Drain Current-Continuous ^a @ T _j =125°C - Pulse d ^b	I _D	3.6	A
	I _{DM}	12	A
Drain-source Diode Forward Current ^a	I _S	1.25	A
Maximum Power Dissipation ^a	P _D	1.25	W
Operating Junction and Storage Temperature Range	T _j , T _{STG}	-55 to 150	°C

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to Ambient ^a	R _{th JA}	100	°C/W
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Si2302

ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BVDSS	VGS=0V, ID=250µA	20			V
Zero Gate Voltage Drain Current	IDSS	VDS=16V, VGS=0V			1	µA
Gate-Body Leakage	IGSS	VGS=±8V, VDS=0V			±100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	VGS(th)	VDS=VGS, ID=-250µA	0.5	0.8	1.5	V
Drain-Source On-State Resistance	RDS(ON)	VGS=4.5V, ID=2.8A		65	80	mΩ
		VGS=2.5V, ID=2.0A		90	110	
Forward Transconductance	gFS	VGS=5V, ID=5A		5		S
DYNAMIC CHARACTERISTICS						
Input Capacitance	Ciss	VDS=10V, VGS=0V f=1.0MHz		586		pF
Output Capacitance	Coss			101		pF
Reverse Transfer Capacitance	Crss			59		pF
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	tD(ON)	VDD=10V ID=3.6A, VGEN=4.5V RL=10ohm RGEN=10ohm		6.5		ns
Rise Time	tr			32.1		ns
Turn-Off Delay Time	tD(OFF)			58.4		ns
Fall Time	tf			48		ns
Total Gate Charge	Qg	VDS=10V, ID=1A VGS=4.5V		6		nC
Gate-Source Charge	Qgs			1.35		nC
Gate-Drain Charge	Qgd			1.5		nC

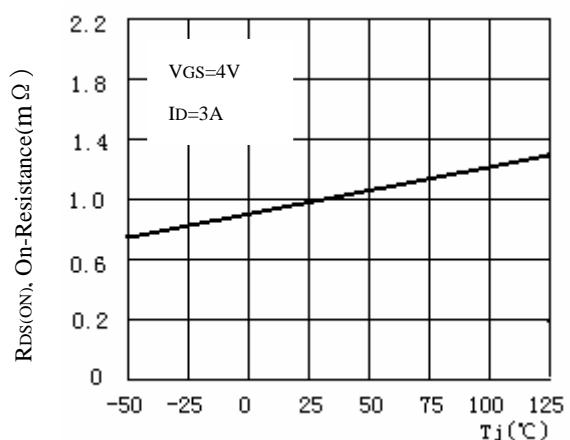
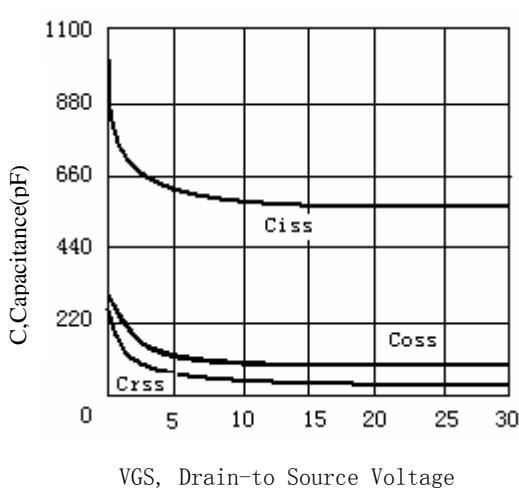
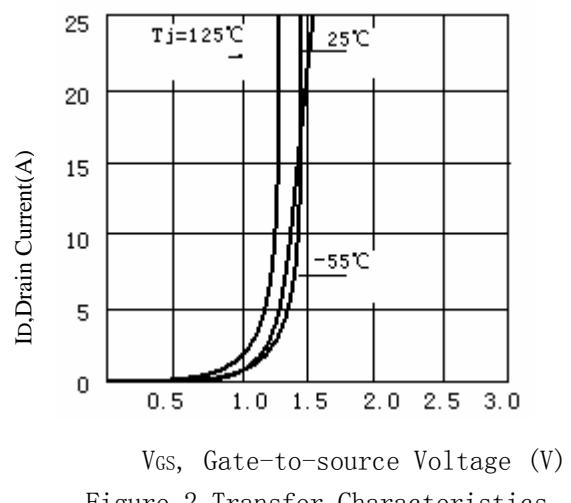
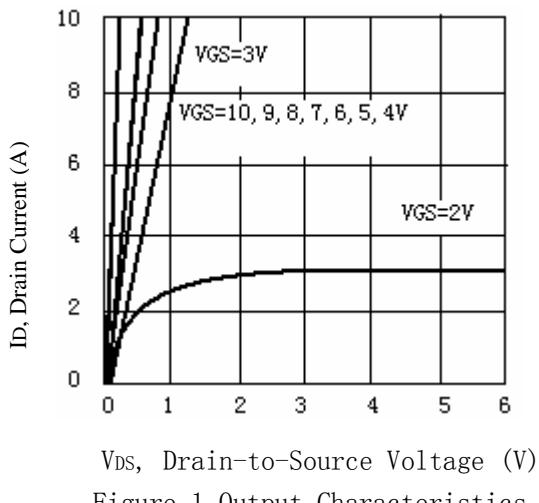
Si2302

ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS						
Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _D =1.25A		0.84	1.2	V

Notes

- a. Surface Mounted on FR4 Board, t ≤ 10sec
- b. Pulse Test: Pulse Width ≤ 300Us, Duty ≤ 2%
- c. Guaranteed by design, not subject to production testing.



Si2302

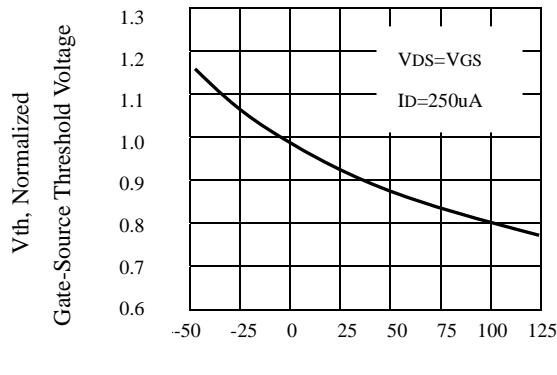


Figure 5. Gate Threshold Variation
With Temperature

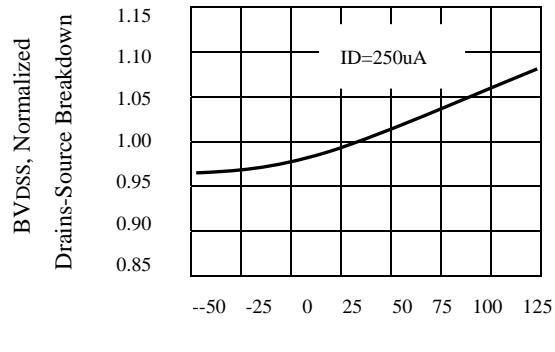


Figure 6. Breakdown Voltage Variation
With Temperature

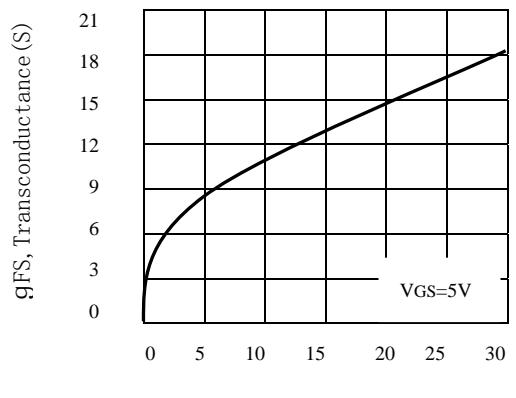


Figure 7. Transconductance Variation
With Drain Current

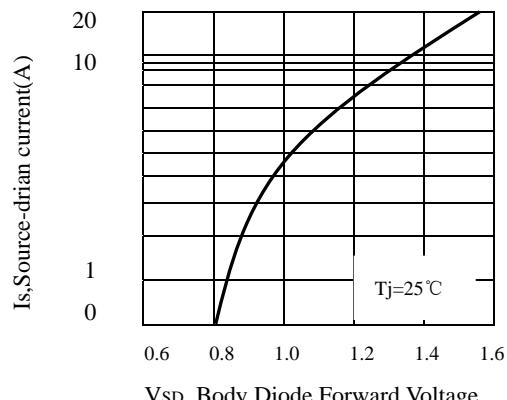


Figure 8. Body Diode Forward Voltage
Variation with Source Current

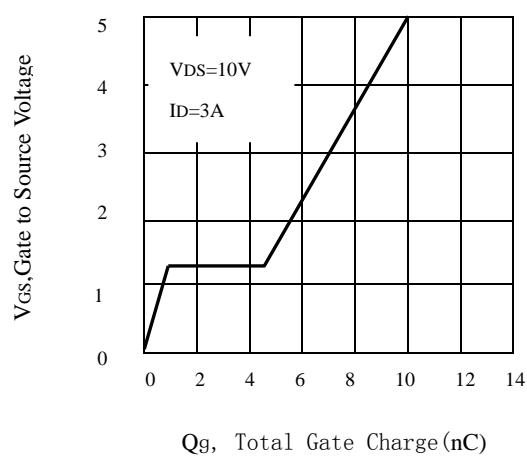


Figure 9. Gate Charge

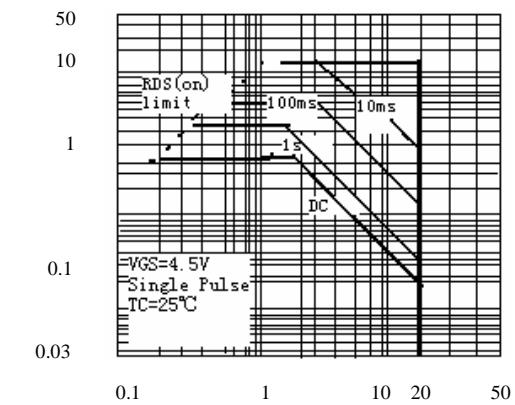


Figure 10. Maximum Safe Operating Area